

FCC TEST REPORT

For

Anker Technology Co., Limited

SoundCore

Model No.: A3102

Prepared For : Anker Technology Co., Limited

Address : Room 1318-19, Hollywood Plaza, 610 Nathan Road, Mongkok, Kowloon,

Hongkong

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Report Number : SZAWW180601011-01

Date of Test : Jun. 01~06, 2018

Date of Report : Jun. 06, 2018



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TEST REPORT

Applicant : Anker Technology Co., Limited

Manufacturer : Anker Technology Co., Limited

Product Name : SoundCore

Model No. : A3102

Trade Mark : ANKER

Rating(s) : Input: DC 5V, 1A (with DC 3.7V, 4400mAh Battery inside)

Test Standard(s) : FCC Part15 Subpart C 2017, Section 15.247

Test Method(s) : **ANSI C63.10: 2013**

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test			Ju	n. 01~06, 2018	300	
Anbotek Anbotek	MOTE		Anbote Zan	Juj.	A potek	
Prepared by	Ambotek	Anbolo	Andotek	anbotek	Anbor	ak hote
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botek Anbotek	FICE			win	(Ass.	
	Anboio		Anbore	Annatek	nbotek	
Reviewer		day	Motek	Anbo	hotek	Aupore,
			(Super	visor / Calvin		ak abotel
			otek Ambot	Ambore	Ambo	
			botek Ax	on C	ren	
Approved & Authorized	Signer	Anbotek	Yun Ofek	Anbotek	Aupo	hotek
	k abotek	Anboten	(Man	ager / Tom Ch	nen)	All



1. General Information

1.1. Client Information

Applicant	:	Anker Technology Co., Limited
Address	:	Room 1318-19, Hollywood Plaza, 610 Nathan Road, Mongkok, Kowloon, Hongkong
Manufacturer	:	Anker Technology Co., Limited
Address	:	Room 1318-19, Hollywood Plaza, 610 Nathan Road, Mongkok, Kowloon, Hongkong

1.2. Description of Device (EUT)

Product Name	: SoundCore	Anbotek Anbote Anbo	Anbotek Anbote
Model No.	: A3102	k Aupotek Aupote Aur	stek Anbotek Anbot
Trade Mark	: ANKER	otek Anbotek Anbote Ant	botek Anbotek Anb
Test Power Supply	: AC 240V, 60 DC 3.7V Bate	Hz for adapter/ AC 120V, 60Hz for adapteery inside	Anbotek Anbotek
	Operation Fre	quency: 2402MHz~2480MHz	Z Anbotek Al. abotek
	Transfer Rate	1/2/3 Mbits/s	Anbo. Atek Anbote
Product	Number of C	annel: 79 Channels	ter Anbootek Anb
Description	Modulation T	ype: GFSK, π/4-DQPSK,	8-DPSK
	Antenna Type	: PIFA Antenna	Anbote Anb hotek
	Antenna Gair	(Peak): 2 dBi	Anbote. Anh hotek

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

1.3. Auxiliary Equipment Used During Test

70	Adapter	• •	Manufacturer: ZTE	
			M/N: STC-A2050I1000USBA-C	
			S/N: 201202102100876	No.
K			Input: 100-240V~50/60Hz 0.3A	250
			Output: DC 5V, 1000mA	30

1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

P	retest Mode	Description						
hotek	Mode 1	otek	Anbotek	Aupo	CH00	Anbotek	Anbote.	Ann
Anbotek	Mode 2	nbotek	Anbotek	Aup.	CH39	Anbotek	Anboro	F
Anbotel	Mode 3	nbotel	Anbote	-V.	CH78	Anbotel	Anbote	*eK
Anbe	Mode 4	r. Vupc	stek Ank	eeping T	X+ Char	ging Mode	stek Anbr	_+e

For Conducted Emission							
Final Test Mode	Description						
Mode 4	Keeping TX+ Charging Mode						

For Radiated Emission							
Final Test Mode Description							
Mode 1	CH00 And Chock						
Mode 2	CH39						
Mode 3	CH78						
Mode 4	Keeping TX+ Charging Mode						

Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
 - (2) The data rate was set in 1Mbps for radiated emission due to the highest RF output power.



1.5. List of channels

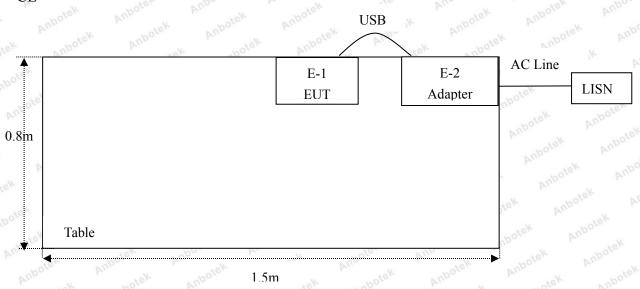
Channel	Freq. (MHz)								
00	2402	Anb 17	2419	34	2436	51	2453	68	2470
01	2403	18	2420	35	2437	52	2454	69	2471
02	2404	19	2421	36	2438	53	2455	70	2472
03	2405	20	2422	37	2439	54	2456	71	2473
04	2406	21	2423	38	2440	55	2457	72	2474
05	2407	22	2424	39	2441	56	2458	73	2475
05	2408	23	2425	40	2442	57	2459	74	2476
10 N	2409	24	2426	41 Anb)	2443	58	2460	75	2477
08	2410	25	2427	42	2444	59	2461	76	2478
09	2411	26	2428	43	2445	60	2462	ote*77	2479
10	2412	27	2429	44	2446	61	2463	78	2480
p.hPote	2413	28	2430	45	2447	62	2464		
12,000	2414	29	2431	46	2448	63	2465		
13	2415	30	2432	47,000	2449	64	2466		
14	2416	31	2433	48	2450	65	2467	5,00	
15	2417	32	2434	49	2451	66	2468		
16	2418	33	2435	50	2452	67	2469		

Note:

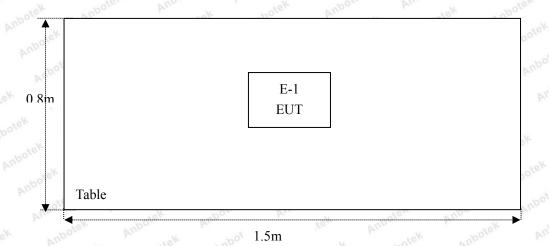
- 1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
- 2. EUT built-in battery-powered, fully-charged battery use of the test battery.

1.6. Description Of Test Setup

CE



RE





1.7. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
o ^{tek} 1.	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 17, 2017	1 Year
2	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 17, 2017	1 Year
4.	Spectrum Analysis	Agilent	E4407B	US39390582	Nov. 17, 2017	1 Year
5.	Spectrum Analysis	Agilent	N9038A	MY53227295	Nov. 17, 2017	1 Year
6.	Preamplifier	SKET Electronic	BK1G18G30D	KD17503	Nov. 17, 2017	1 Year
P7.00	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
8.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 20, 2017	1 Year
9.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 20, 2017	1 Year
10.	Loop Antenna	Schwarzbeck	HFH2-Z2	100047	Nov. 17, 2017	1 Year
MI.	Horn Antenna	Schewarzbeck	BBHA9170	9170-375	Nov. 17, 2017	1 Year
12.	Pre-amplifier	SONOMA	310N	186860	Nov. 17, 2017	1 Year
13.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
14.	RF Test Control System	YIHENG	YH3000	2017430	Nov. 18, 2017	1 Year
15.	Power Sensor	DAER	RPR3006W	15I00041SN045	Nov. 17, 2017	1 Year
16.	Power Sensor	DAER	RPR3006W	15I00041SN046	Nov. 17, 2017	1 Year
17.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 18, 2017	1 Year
18.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Nov. 18, 2017	1 Year
19.	Signal Generator	Agilent	E4421B	MY41000743	Nov. 18, 2017	1 Year
20.	DC Power Supply	LW Anno	TPR-6410D	349315	Nov. 01, 2017	1 Year
21.	Constant Temperature Humidity Chamber	Sertep	ZJ-HWHS80B	ZJ-17042804	Nov. 01, 2017	1 Year

1.8. Measurement Uncertainty

Radiation Uncertainty	:	Ur = 3.9 dB (Horizontal)	Anbotek	Anbote Ani
		Ur = 3.8 dB (Vertical)	tek Anbotek	Aupor Au
		Anbotek Anbote Ans	botek Anbotek	Anbo
Conduction Uncertainty	:	Uc = 3.4 dB	abotek Anbo	rek Anbo

1.9. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

All Emissions tests were performed at Shenzhen Anbotek Compliance Laboratory Limited. at 1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102

2. Summary of Test Results

Standard Section	Test Item	Result
15.203/15.247(c)	Antenna Requirement	PASS
15.207	Conducted Emission	PASS
15.205/15.209	Spurious Emission	PASS
15.247(b)(1)	Conducted Peak Output Power	PASS
15.247(a)(1)	20dB Occupied Bandwidth	PASS
15.247(a)(1)	Carrier Frequencies Separation	PASS
15.247(a)(1)	Hopping Channel Number	PASS
15.247(a)(1)	Dwell Time	PASS
15.247(d)	Band Edge	PASS

3. Conducted Emission Test

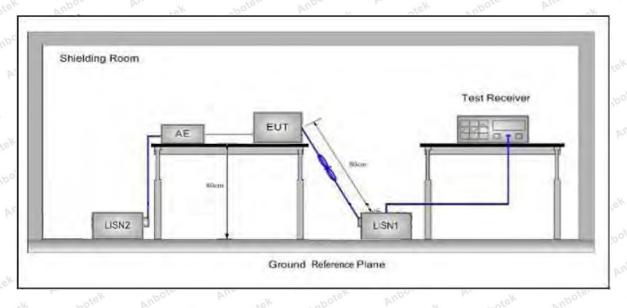
3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.20	7 Anbore And botek	Anbotek Anbo tek				
	F	Maximum RF Line Voltage (dBuV)					
	Frequency	Quasi-peak Level	Average Level				
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *				
	500kHz~5MHz	56	46				
	5MHz~30MHz	60	50 Dollar Am				

Remark: (1) *Decreasing linearly with logarithm of the frequency.

(2) The lower limit shall apply at the transition frequency.

3.2. Test Setup



3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

3.4. Test Data

Please to see the following pages.



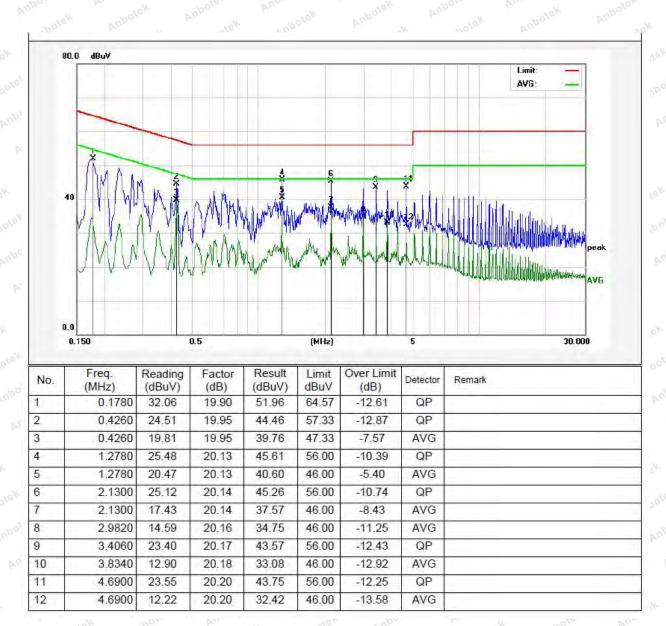
Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line

Tem.: 25.4°C Hum.: 54%



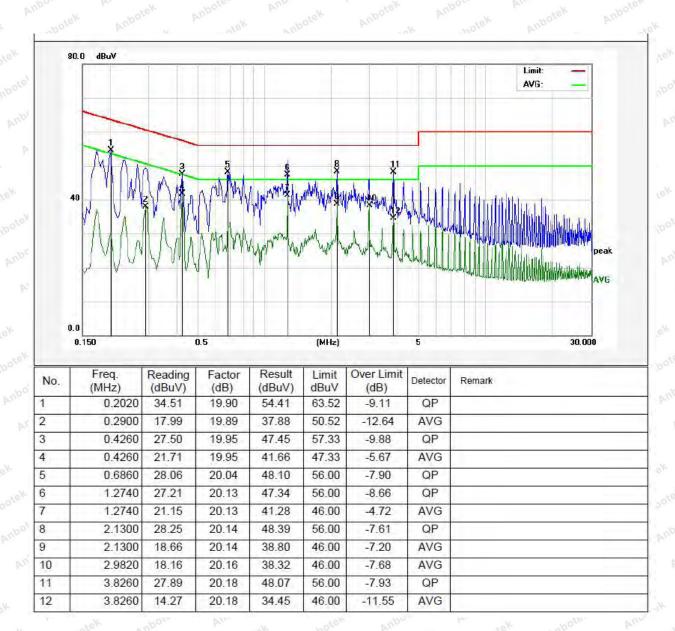
Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Neutral Line

Tem.: 25.4°C Hum.: 54%



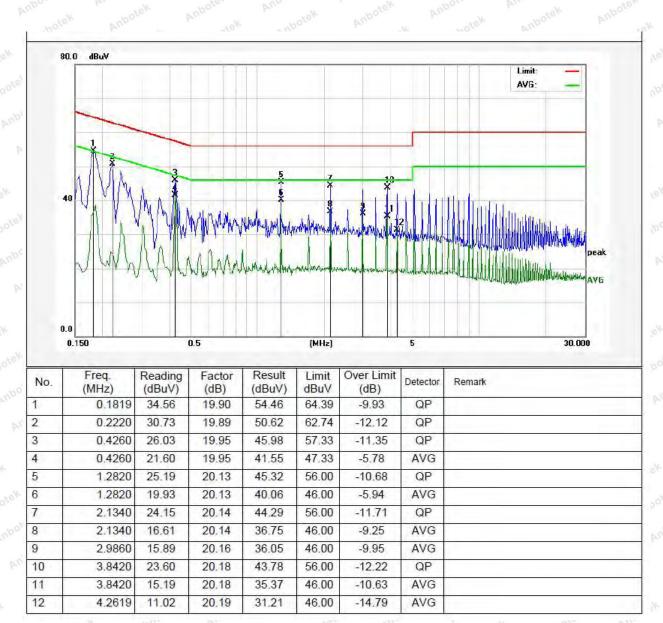
Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 120V, 60Hz for adapter

Comment: Live Line

Tem.: 25.4°C Hum.: 54%



Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 120V, 60Hz for adapter

Comment: Neutral Line

17.84

25.51

14.52

25.71

16.09

20.16

20.18

20.18

20.20

20.20

38.00

45.69

34.70

45.91

36.29

46.00

56.00

46.00

56.00

46.00

2.9860

3.8380

3.8420

4.6940

4.6940

8

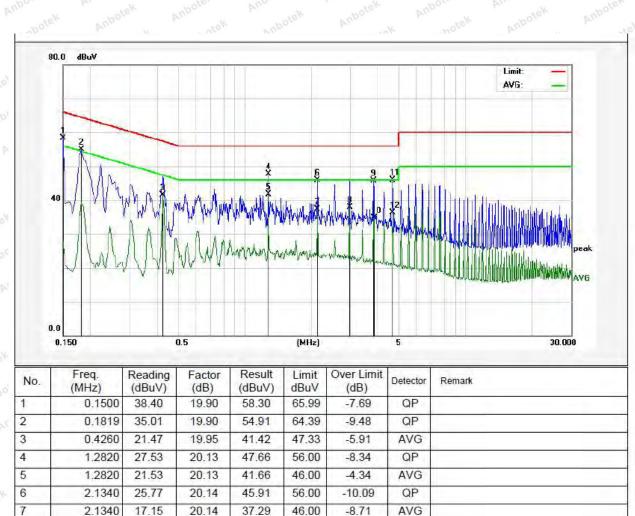
9

10

11

12

Tem.: 25.4°C Hum.: 54%



-8.00

-10.31

-11.30

-10.09

-9.71

AVG

QP

AVG

QP

AVG



4. Radiation Spurious Emission and Band Edge

4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.20	99 and 15.205	Al. botek	Anboten	Aubo stek
	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz~0.490MHz	2400/F(kHz)	ibotek - Anbo	co Fun	300
	0.490MHz-1.705MHz	24000/F(kHz)	Anbotek Ar	Pore VIII	30
	1.705MHz-30MHz	30	Anbatek	Anbore P	30
Test Limit	30MHz~88MHz	100	40.0	Quasi-peak	3.04
	88MHz~216MHz	150	43.5	Quasi-peak	3 _{botek}
	216MHz~960MHz	200	46.0	Quasi-peak	3 bote
	960MHz~1000MHz	500	54.0	Quasi-peak	atek 3
	Above 1000MHz	500	54.0	Average	3
	Above 1000MHZ	botek - Anbot	74.0	Peak	Amb 3

Remark:

- (1)The lower limit shall apply at the transition frequency.
- (2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

4.2. Test Setup

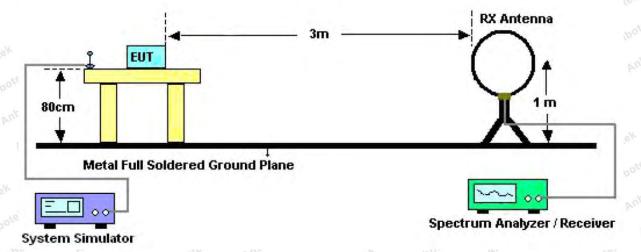


Figure 1. Below 30MHz



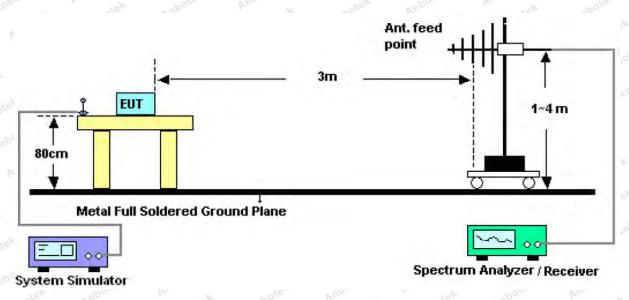


Figure 2. 30MHz to 1GHz

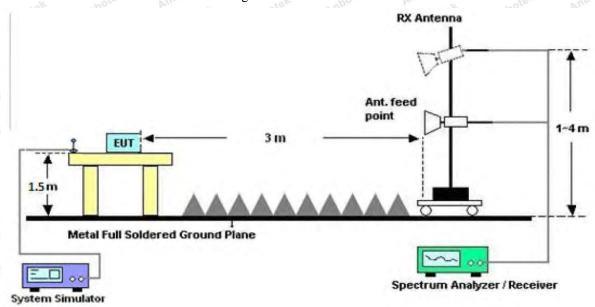


Figure 3. Above 1 GHz

4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying

aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW = 1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW = 30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW = 300kHz, Detector = Quasi-Peak, Trace mode = Max hold, Sweep- auto couple.

For above 1GHz, Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

4.4. Test Data

PASS

During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation which is worse case.

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

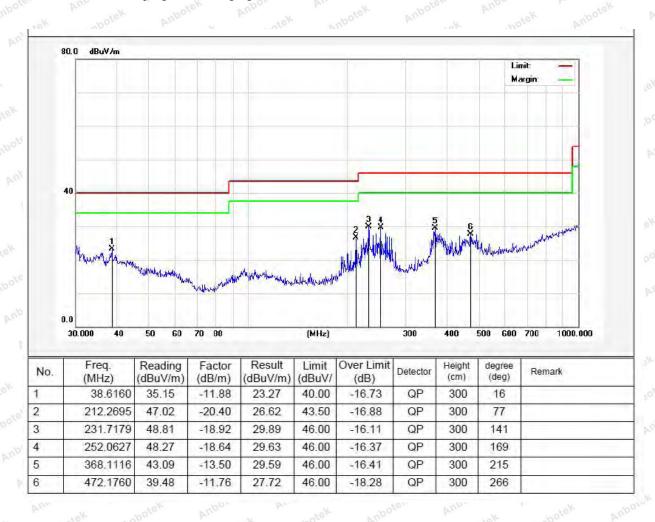


Test Results (30~1000MHz)

Job No.: SZAWW180601011-01 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Keeping TX+ Charging Mode Polarization: Horizontal



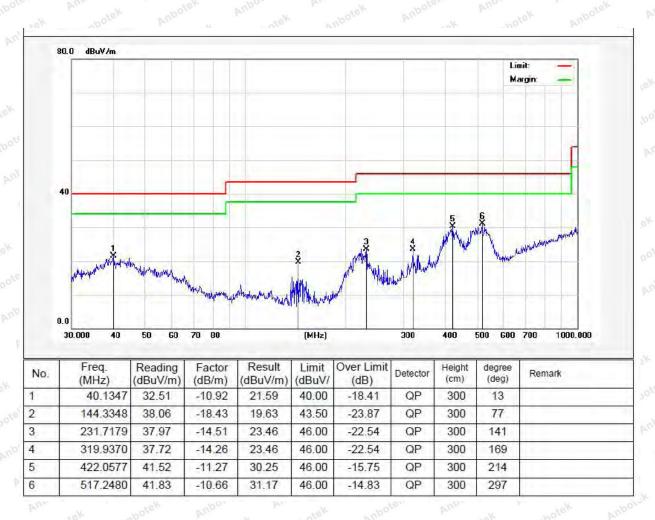


Test Results (30~1000MHz)

Job No.: SZAWW180601011-01 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Keeping TX+ Charging Mode Polarization: Vertical



Test Results (1GHz-25GHz)

Test Mode: 0	CH00			Test	channel: Lowe	st		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	38.34	34.04	6.58	34.09	44.87	74.00	-29.13	bote V
7206.00	32.51	37.11	7.73	34.50	42.85	74.00	-31.15	No Vel
9608.00	32.08	39.31	9.23	34.79	45.83	74.00	-28.17	V
12010.00	*	tek	hbotek p	upor	An spotek	74.00	Anbor	V
14412.00	* And	otek	nbotek	Aupoter	Aur	74.00	Anbor	e ^X V
4804.00	42.83	34.04	6.58	34.09	49.36	74.00	-24.64	$H_{l_{\otimes d}}$
7206.00	34.36	37.11	7.73	34.50	44.70	74.00	-29.30	H
9608.00	31.60	39.31	9.23	34.79	45.35	74.00	-28.65	Anbore H
12010.00	* Anbote	Anbo	18K	abotek	Anboten	74.00	Anbotek	H
14412.00	Lek * Anb	step by	loor b	- abotek	Anboten	74.00	anbotek	H
			Α	verage Value	e	0.0		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	26.96	34.04	6.58	34.09	33.49	54.00	-20.51	V
7206.00	21.08	37.11	7.73	34.50	31.42	54.00	-22.58	V
9608.00	20.10	39.31	9.23	34.79	33.85	54.00	-20.15	V
12010.00	botek * A	100	anbotek	Anbore	Aug.	54.00	Anbor	V
14412.00	Anbotek	Anbor	Anotek	Anbote	Anbo	54.00	lek Ant	V
4804.00	31.30	34.04	6.58	34.09	37.83	54.00	-16.17	Yupoter.
7206.00	23.33	37.11	7.73	34.50	33.67	54.00	-20.33	μΉ
9608.00	19.91	39.31	9.23	34.79	33.66	54.00	-20.34	Н
12010.00	*	potek	Aupore	And	Anbotek	54.00	abote	Н
14412.00	*	botek	Anbote.	An	k anbote	54.00	ok by	o ^{tek} H

Test Results (1GHz-25GHz)

Test Mode: 0	CH39			Test	Test channel: Middle				
				Peak Value					
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.	
4882.00	36.63	34.38	6.69	34.09	43.61	74.00	-30.39	boteV	
7323.00	31.38	37.22	7.78	34.53	41.85	74.00	-32.15	anb Vel	
9764.00	31.07	39.46	9.35	34.80	45.08	74.00	-28.92	V	
12205.00	*	tek	abotek p	upote	W. Potek	74.00	Anbo	V	
14646.00	* And	otek	nbotek	Aupoten	Aur	74.00	Anbor	v V	
4882.00	40.78	34.38	6.69	34.09	47.76	74.00	-26.24	H	
7323.00	33.08	37.22	7.78	34.53	43.55	74.00	-30.45	H	
9764.00	30.43	39.46	9.35	34.80	44.44	74.00	-29.56	Aupor H	
12205.00	* Anbote	Anbo	rek by	botek	Anboten	74.00	Anbotek	PΗ	
14646.00	tek * Amb	Yek by	loor b	abotek	Anboten	74.00	nbotek	H	
			A	verage Valu	e	0.0	100		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.	
4882.00	25.58	34.38	6.69	34.09	32.56	54.00	-21.44	V	
7323.00	20.15	37.22	7.78	34.53	30.62	54.00	-23.38	V	
9764.00	19.27	39.46	9.35	34.80	33.28	54.00	-20.72	V	
12205.00	potek * A	lpo.	Mabotek	Auporer	And	54.00	Aupor	V	
14646.00	Anbot *	Anbor	Abotek	Anbote	Anbo	54.00	lek but	V	
4882.00	29.73	34.38	6.69	34.09	36.71	54.00	-17.29	Yupofe,	
7323.00	22.28	37.22	7.78	34.53	32.75	54.00	-21.25	ATH	
9764.00	18.94	39.46	9.35	34.80	32.95	54.00	-21.05	Ho	
12205.00	**	potek	Aupote	Anbotek	Anbotek	54.00	nbote	Н	
14646.00	*	botek	Anboie	Ann	k abote	54.00	~/r	ote ^K H	

Test Results (1GHz-25GHz)

Test Mode: C	CH78			Test	channel: Highe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	36.07	34.72	6.79	34.09	43.49	74.00	-30.51	boteV
7440.00	31.01	37.34	7.82	34.57	41.60	74.00	-32.40	Vap Vek
9920.00	30.74	39.62	9.46	34.81	45.01	74.00	-28.99	V
12400.00	***************************************	tek	abotek p	upor	An.	74.00	Anbo	V
14880.00	*	otek	anbotek	Anboten	Yu. Hotek	74.00	Vupo.	e ^X V
4960.00	40.11	34.72	6.79	34.09	47.53	74.00	-26.47	H
7440.00	32.66	37.34	7.82	34.57	43.25	74.00	-30.75	H
9920.00	30.05	39.62	9.46	34.81	44.32	74.00	-29.68	Anbot H
12400.00	* Anbote	Aupe	rek k	abotek	Vupore,	74.00	anbotek	Ĥ
14880.00	rek * Amb	Sex V.	100 F B	abotek	Aupolen	74.00	anbotek	HAM
			A	verage Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	25.17	34.72	6.79	34.09	32.59	54.00	-21.41	V
7440.00	19.87	37.34	7.82	34.57	30.46	54.00	-23.54	V
9920.00	19.02	39.62	9.46	34.81	33.29	54.00	-20.71	V
12400.00	poter * A	lpo rek	- nbotek	Anbote	Ans	54.00	Anbor	V
14880.00	Anbota*	Aupor	Andotek	Anbore	Anb	54.00	lek but	V
4960.00	29.27	34.72	6.79	34.09	36.69	54.00	-17.31	Yupole H
7440.00	21.97	37.34	7.82	34.57	32.56	54.00	-21.44	P.H.
9920.00	18.65	39.62	9.46	34.81	32.92	54.00	-21.08	Huk
12400.00	*	potek	Aupor	And	Anbotek	54.00	pote	H
14880.00	*	Anbotek	Anbote	Vu.	Anbote	54.00	ek w	ote ^K H

Remark

- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor
- 3. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.



Radiated Band Edge:

Test Mode: 0	CH00			Test	channel: Lowe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2390.00	46.54	29.15	3.41	34.01	45.09	74.00	-28.91	Hek
2400.00	63.86	29.16	3.43	34.01	62.44	74.00	-11.56	Hote
2390.00	47.44	29.15	3.41	34.01	45.99	74.00	-28.01	V
2400.00	66.29	29.16	3.43	34.01	64.87	74.00	-9.14	V
			A	verage Valu	ie			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2390.00	36.27	29.15	3.41	34.01	34.82	54.00	-19.19	Hote
2400.00	47.72	29.16	3.43	34.01	46.30	54.00	-7.70	Hanb
2390.00	36.47	29.15	3.41	34.01	35.02	54.00	-18.98	V
2400.00	49.72	29.16	3.43	34.01	48.30	54.00	-5.70	ote V

Test Mode: 0	CH78			Test	channel: Highe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	49.08	29.28	3.53	34.03	47.86	74.00	-26.14	, ho He
2500.00	47.56	29.30	3.56	34.03	46.39	74.00	-27.61	Hotel
2483.50	50.54	29.28	3.53	34.03	49.32	74.00	-24.68	V
2500.00	48.91	29.30	3.56	34.03	47.74	74.00	-26.26	V
			A	verage Valu	ie			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	39.14	29.28	3.53	34.03	37.92	54.00	-16.08	An Hten
2500.00	36.61	29.30	3.56	34.03	35.44	54.00	-18.56	Habo
2483.50	40.65	29.28	3.53	34.03	39.43	54.00	-14.57	V
2500.00	36.84	29.30	3.56	34.03	35.67	54.00	-18.33	tek V

Remark:

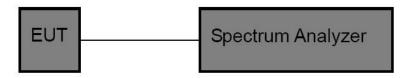
- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level = Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor

5. Maximum Peak Output Power Test

5.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (b)(3	Anb	Anbotek	Anbore An	
Test Limit	1W or 125mW	Anu hotek	Anbotek	Aupor	P.

5.2. Test Setup



5.3. Test Procedure

- 1. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,
- 2. Spectrum Setting:

RBW > the 20 dB bandwidth of the emission being measured

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

VBW ≥ RBW

Sweep = auto

Detector function = peak

Trace = max hold

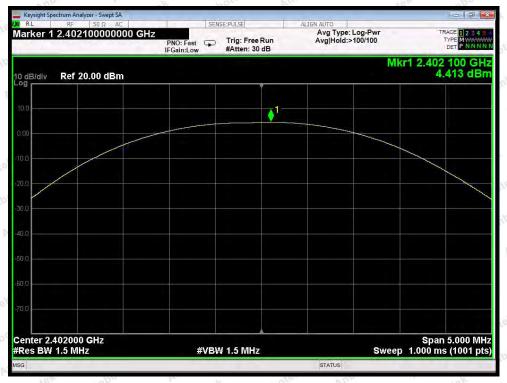
5.4. Test Data

Test Item	:	Max. peak output power	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	24 ℃
Test Result	:	PASS	Humidity	:	55%RH

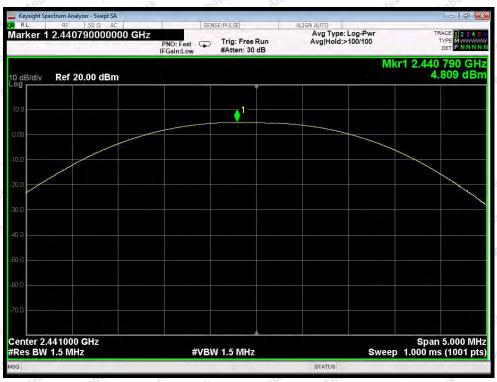
20	Channel Frequency (MHz)	Peak Power output (dBm)	Limit (dBm)	Results	Modulation	
	2402	4.413	30	PASS	BDR	
-	2441	4.809	30	PASS	BDR	
YSY.	2480	3.908	30	PASS	BDR	
-4	2402	4.393	20.96	PASS	EDR	
700	2441	4.236	20.96	PASS	EDR	
An	2480	3.364	20.96	PASS	EDR	

Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of (8DPSK) is attached in the following pages.



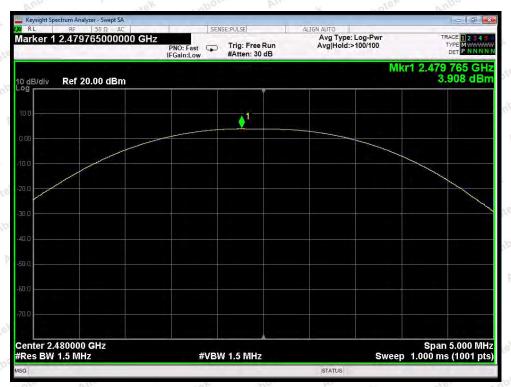


Test Mode: BDR---Low

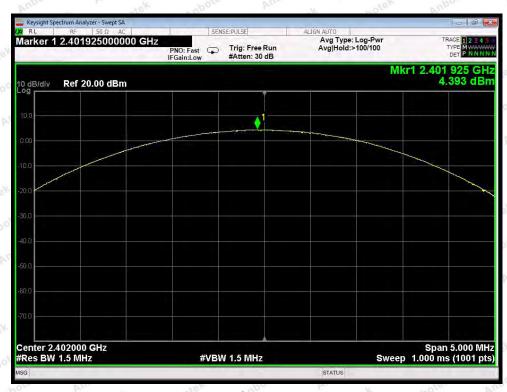


Test Mode: BDR---Middle



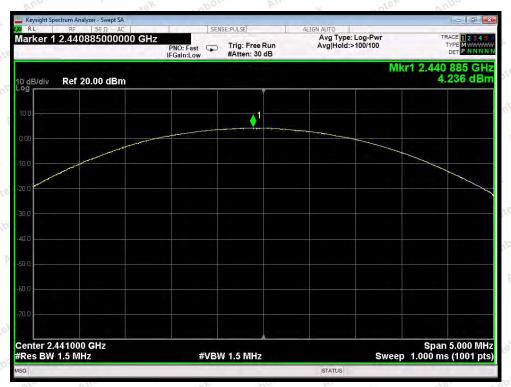


Test Mode: BDR---High

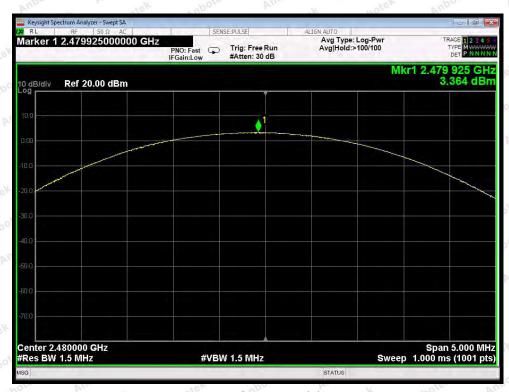


Test Mode: EDR---Low





Test Mode: EDR---Middle



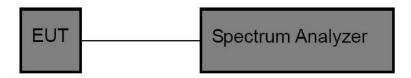
Test Mode: EDR---High

6. 20DB Occupy Bandwidth Test

6.1. Test Standard

Te	est Standard	FCC Part15 C Section 15.247 (a)(1)			ber
100		1.0	- 17		the state of the s

6.2. Test Setup



6.3. Test Procedure

Using the following spectrum analyzer settings:

- 1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

6.4. Test Data

Test Item : 20dB BW Test Mode : CH Low ~ CH High

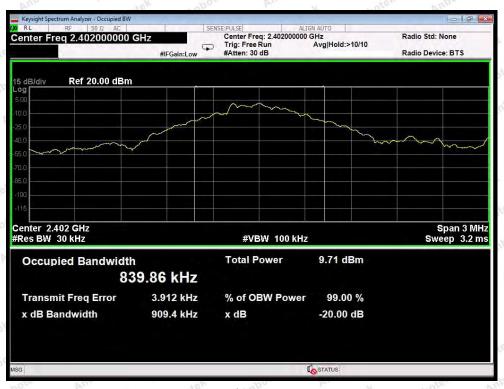
Test Voltage : DC 3.7V Battery inside Temperature : 24°C

Test Result : PASS Humidity : 55%RH

Channel	Frequency(MHz)	20dB Down BW(kHz)	Modulation Mode	
Low	2402	909.4	BDR	
Middle	2441	871.3	BDR	
High	2480	871.6	BDR	
Low	2402	1209.0	EDR	
Middle	2441	1211.0	EDR	
High	2480	1209.0	EDR	

Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of (8DPSK) is attached in the following pages.



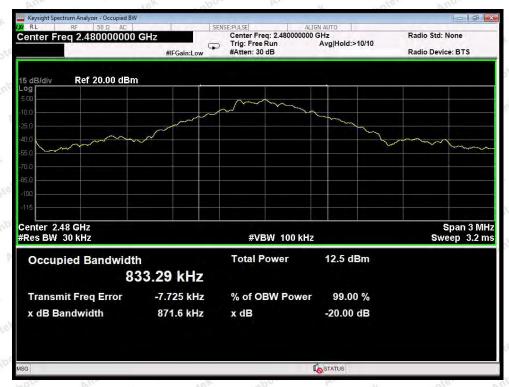


Test Mode: BDR---Low



Test Mode: BDR---Middle



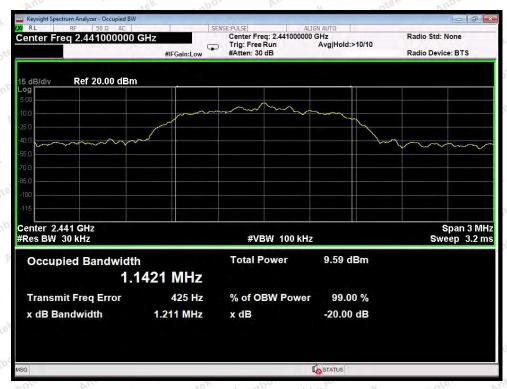


Test Mode: BDR---High

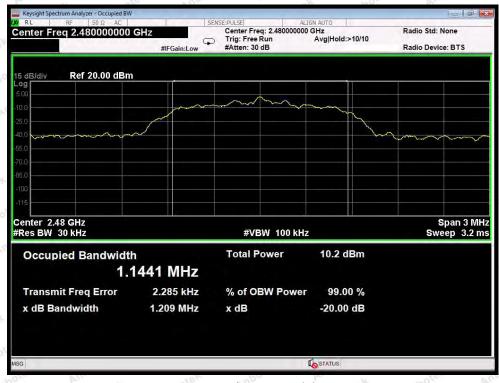


Test Mode: EDR----Low





Test Mode: EDR---Middle



Test Mode: EDR---High

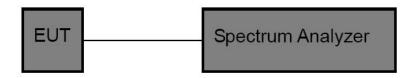


7. Carrier Frequency Separation Test

7.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Anbotek	Anbo. stek
Test Limit	>25KHz or >two-thirds of the 20 dB bandwidth	Anbotek	Anbo

7.2. Test Setup



7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

- 1. Span= Wide enough to capture the peaks of two adjacent channels
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

7.4. Test Data

Test Item	:	Frequency Separation	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	24℃
Test Result	-	PASS	Humidity	-	55%RH

10.7	- AU - U	010	· · · · · · · · · · · · · · · · · · ·	WO	
Channel	Frequency	Separation Read	Limit	Modulation Mode	
Chamiei	(MHz)	Value (kHz)	(kHz)		
Low	2402	1000	909.4	BDR	
Middle	2441	1000	871.3	BDR	
High	2480	1000	871.6	BDR	
Low	2402	1000	806.0	EDR	
Middle	2441	1000	807.3	EDR	
High	2480	1000	806.0	EDR And	

Remark:

- 1. The limit of mode (EDR) is 2/3 of 20dB BW;
- 2. The EDR was tested on (π /4DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.





Test Mode: BDR---Low



Test Mode: BDR---Middle





Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

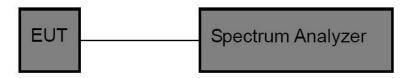


8. Number of Hopping Channel Test

8.1. Test Standard and Limit

Test Standard	FCC Part15 C	Section 15.2	247 (a)(1)	Am	Anbotek	Anbo	Þ.
Test Limit	>15 channels	Anbotek	Anboro	Anhotek	Anbotek	Anbo	

8.2. Test Setup



8.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

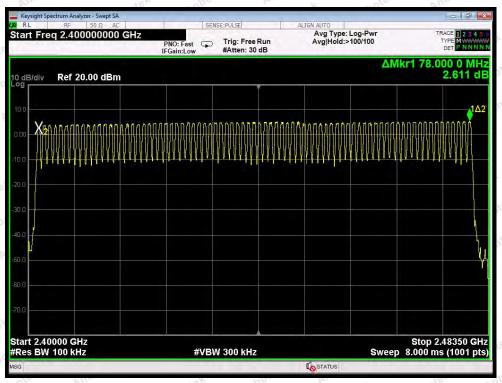
- 1. Span= the frequency band of operation
- 2. Set the RBW = 100kHz.
- 3. Set the VBW = 300kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

8.4. Test Data

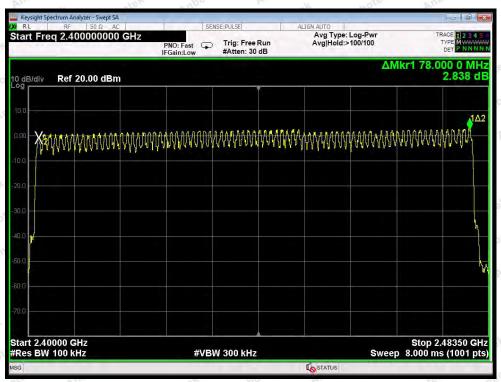
Test Item	: Number of Hopping Frequency	Test Mode :	CH Low ~ CH High
Test Voltage	: DC 3.7V Battery inside	Temperature :	24°C
Test Result	: PASS	Humidity :	55%RH

Hopping Channel Frequency Range		Quantity of Hopping Channel		Quantity of Hopping Channel			
2402-	2480MHz	Anb	79 300tek	Aupor	N. William	>15	upoten





BDR Mode



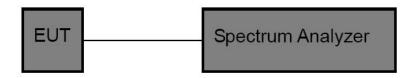
EDR Mode

9. Dwell Time Test

9.1. Test Standard and Limit

Test Standard	FCC Part15	C Section 15.2	247 (a)(1)	Ambotek	Anbotek	Anbo.	pc.
Test Limit	0.4 sec	Anbotek	Auporg	All	Anbotek	Anbo	P

9.2. Test Setup



9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

- 1. Span= zero span, centered on a hopping channel
- 2. Set the RBW = 1 MHz.
- 3. Set the VBW = 1 MHz.
- 4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

9.4. Test Data

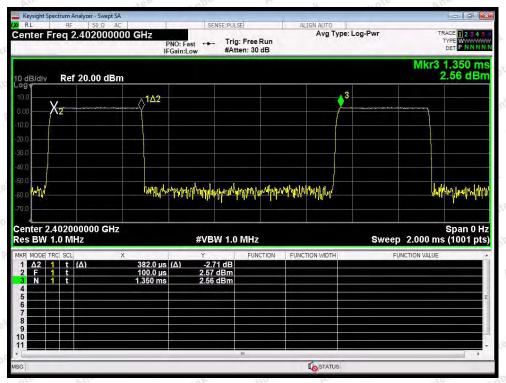
Test Item : Time of Occupancy Test Mode : CH Low ~ CH High

Test Voltage : DC 3.7V Battery inside Temperature : 24° C Test Result : PASS Humidity : 55° RH

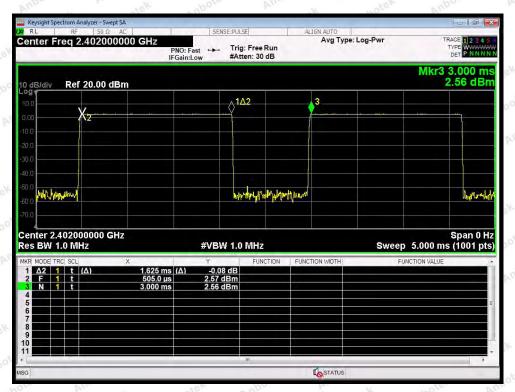
Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)	Modulation
DH1	0.382	time slot length *1600/2 /79 * 31.6	122.24	0.4	BDR
DH3	1.625	time slot length *1600/4 /79 * 31.6	260.00	0.4	BDR
DH5	2.888	time slot length *1600/6 /79 * 31.6	308.05	0.4	BDR
3DH1	0.398	time slot length *1600/2 /79 * 31.6	127.36	0.4	EDR
3DH3	1.650	time slot length *1600/4 /79 * 31.6	264.00	0.4	EDR
3DH5	2.888	time slot length *1600/6 /79 * 31.6	308.05	0.4	EDR

Remark: The EDR was tested on (π /4DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.



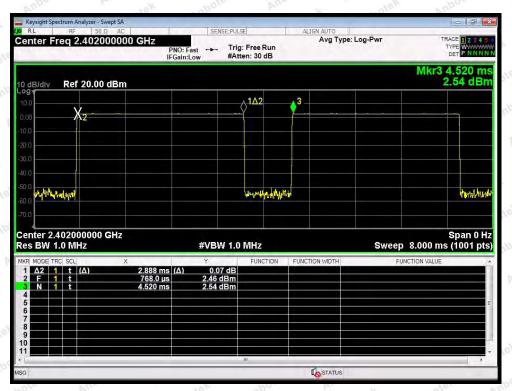


Test Mode: BDR---DH1

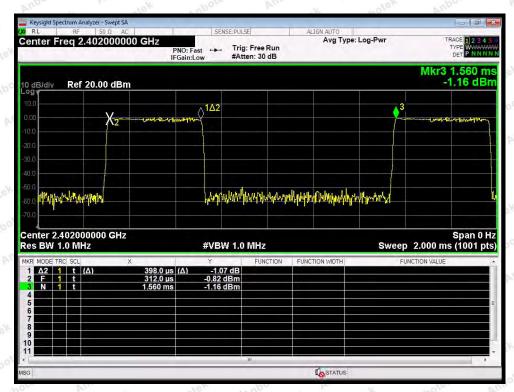


Test Mode: BDR---DH3



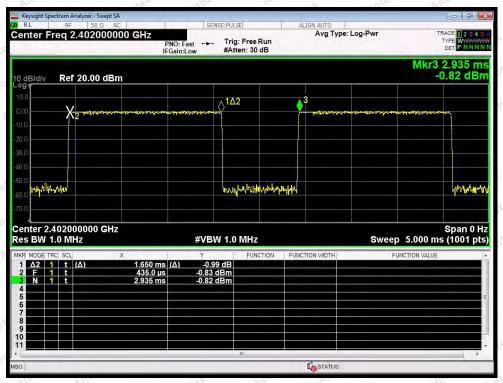


Test Mode: BDR—DH5

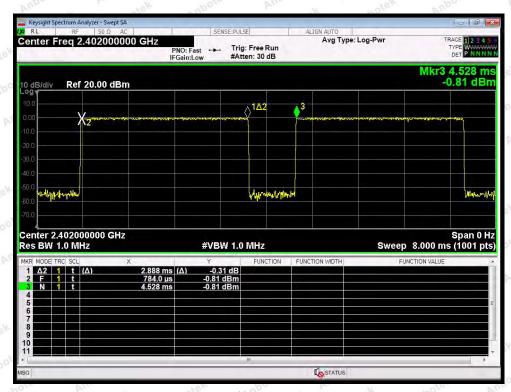


Test Mode: EDR---3DH1





Test Mode: EDR---3DH3



Test Mode: EDR-

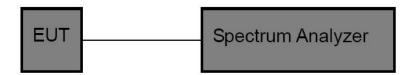


10. 100kHz Bandwidth of Frequency Band Edge Requirement

10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

10.2. Test Setup



10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

- 1. Set the RBW = 100kHz.
- 2. Set the VBW = 300kHz.
- 3. Sweep time = auto couple.
- 4. Detector function = peak.
- 5. Trace mode = \max hold.
- 6. Allow trace to fully stabilize.

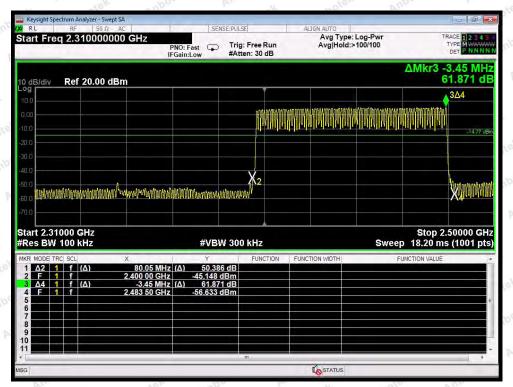
10.4. Test Data

Test Item	:	Band edge	Test Mode	:	CH Low ~ CH Hi	gh
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	24℃	
Test Result	:	PASS	Humidity	:	55%RH	

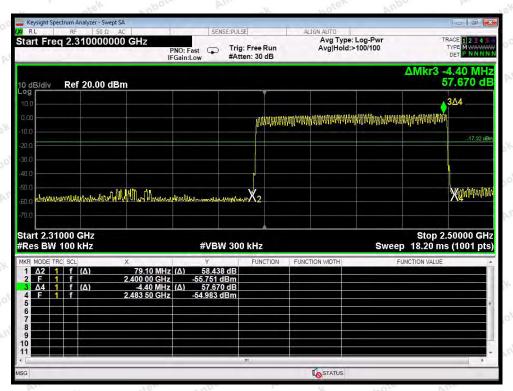
Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of $(\pi/4DQPSK)$ is attached in the following pages.



For Hopping Mode

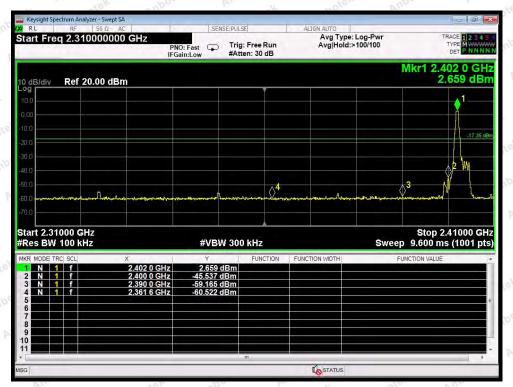


BDR mode



EDR mode

For Non-Hopping Mode



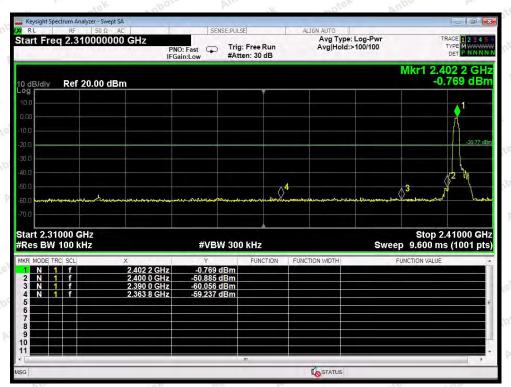
BDR mode -- Lowest



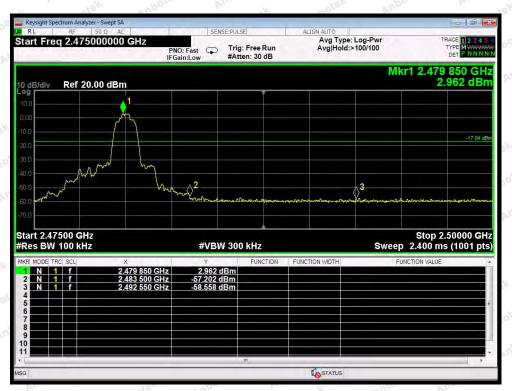
BDR mode -- Highest



For Non-Hopping Mode



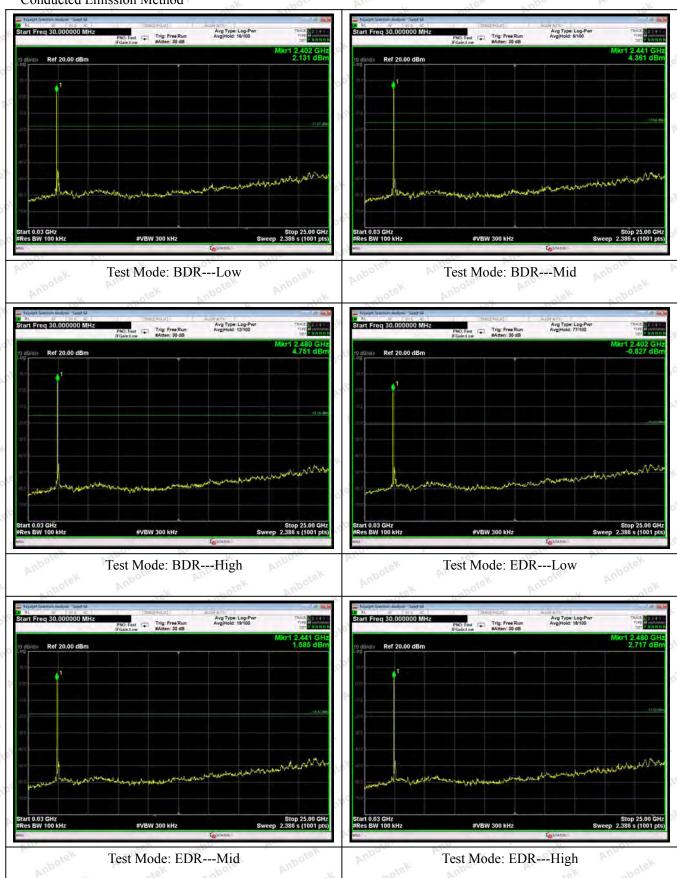
EDR mode -- Lowest



EDR mode -- Highest



Conducted Emission Method





11. Antenna Requirement

11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
	1) 15.203 requirement:
	to, Yu., The special state with
	An intentional radiator shall be designed to ensure that no antenna other than that furnished
	by the responsible party shall be used with the device. The use of a permanently
	attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the
	manufacturer may design the unit so that a broken antenna can be replaced by the user, but
Requirement	the use of a standard antenna jack or electrical connector is prohibited.
	2) 15.247(c) (1)(i) requirement:
	Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed.
	Point-to-point operations may employ transmitting antennas with directional gain greater
	than 6dBi provided the maximum conducted output power of the intentional radiator is
	reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.

11.2. Antenna Connected Construction

The bluetooth antenna is PIFA Antenna which permanently attached, and the best case gain of the antenna is 2 dBi. It complies with the standard requirement.



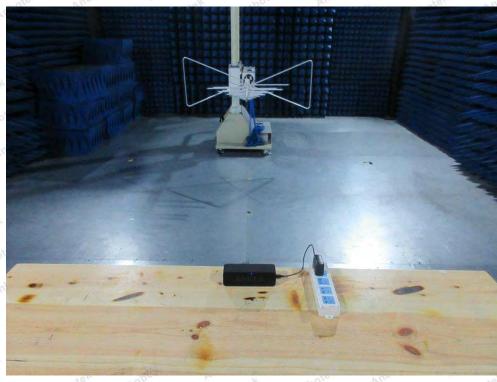


APPENDIX I -- TEST SETUP PHOTOGRAPH





Photo of Radiation Emission Test

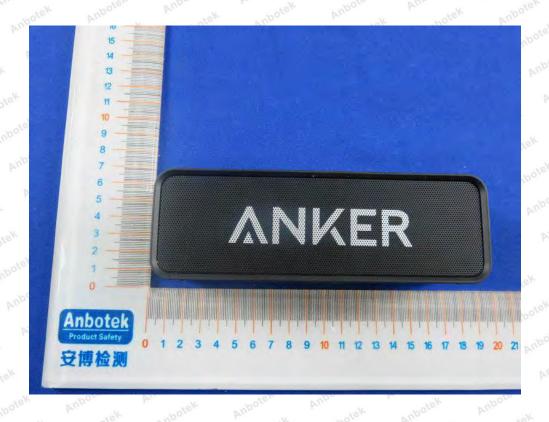






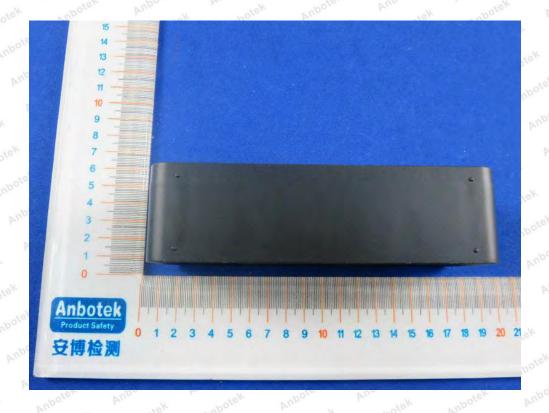


APPENDIX II -- EXTERNAL PHOTOGRAPH





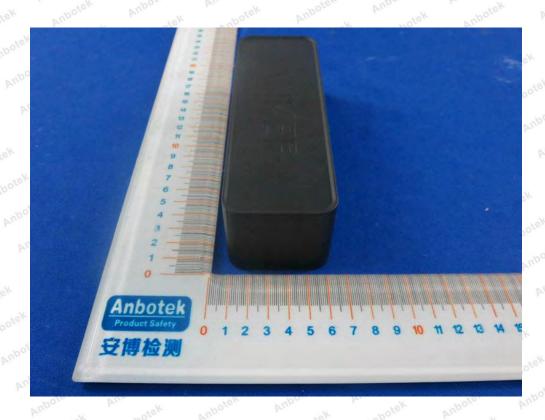












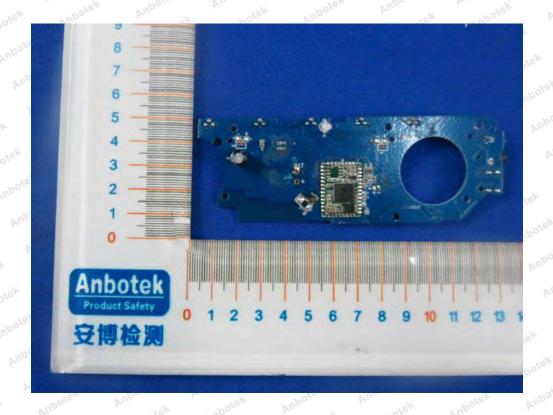


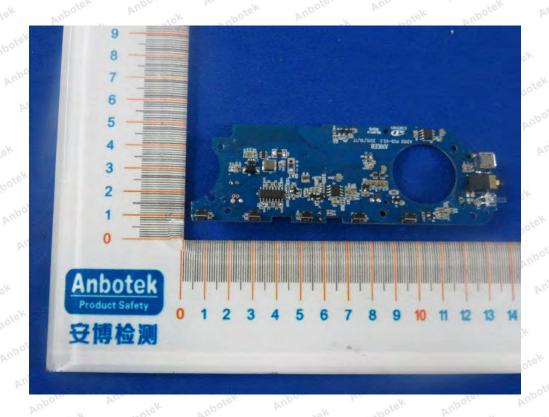
APPENDIX III -- INTERNAL PHOTOGRAPH





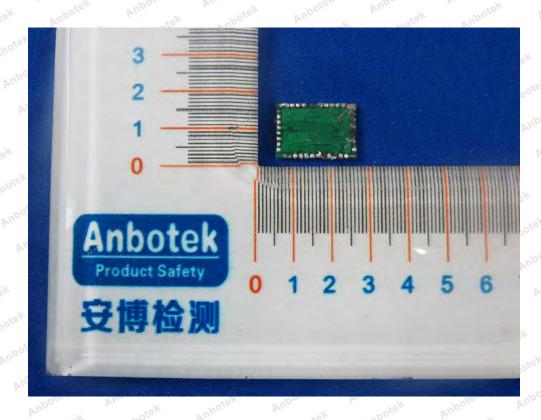




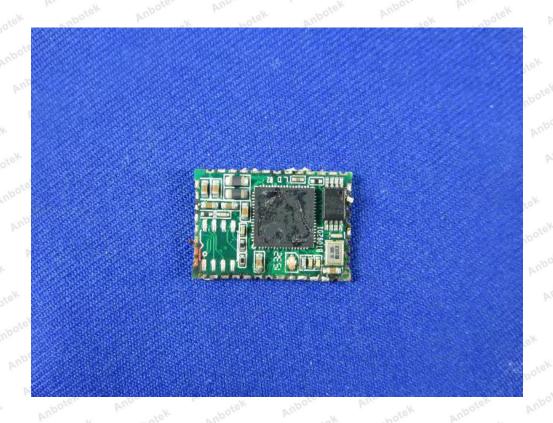


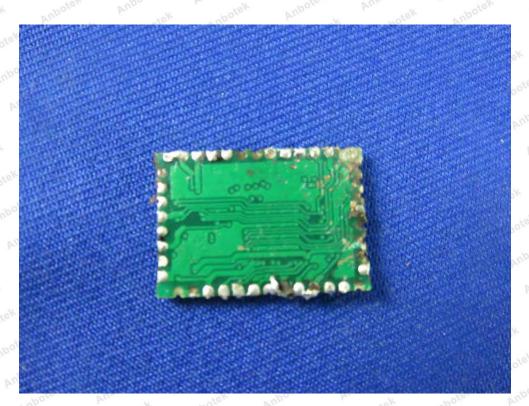












End of report